

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/625,733 NITTA ET AL.	
		Examiner	Art Unit	Page 1 of 1 A. Sefer 2826

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	C	US-2002/0025632	02-2002	Hayashi et al.	438/275
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